

Annex C: Calibration Reports
Tested Model : A7
Report Number: WSCT-ANAB-R&E251000083A-SAR



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 Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Client

WSCT
 Shenzhen

Certificate No.

D2550V2-1015_Aug24

CALIBRATION CERTIFICATE

Object

D2550V2 - SN: 1015

Calibration procedure(s)

QA CAL-05.v12

Calibration Procedure for SAR Validation Sources between 0.7 - 3 GHz

Calibration date

August 16, 2024

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^\circ\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Cal
Power Sensor R&S NRP-33T	SN: 100967	28-Mar-24 (No. 217-04038)	Mar-25
Power Sensor R&S NRP18A	SN: 101859	21-Mar-24 (No. 4030A315007801)	Mar-25
Spectrum Analyzer R&S FSV40	SN: 101832	25-Jan-24 (No. 4030-315007551)	Jan-25
Mismatch; Short [S4188] Attenuator [S4423]	SN: 1152	28-Mar-24 (No. 217-04050)	Mar-25
OCP DAK-12	SN: 1016	05-Oct-23 (No. OCP-DAK12-1016_Oct23)	Oct-24
OCP DAK-3.5	SN: 1249	05-Oct-23 (No. OCP-DAK3.5-1249_Oct23)	Oct-24
Reference Probe EX3DV4	SN: 7349	03-Jun-24 (No. EX3-7349_Jun24)	Jun-25
DAE4ip	SN: 1836	10-Jan-24 (No. DAE4ip-1836_Jan24)	Jan-25

Secondary Standards	ID	Check Date (in house)	Scheduled Check
ACAD Source Box	SN: 1000	28-May-24 (No. 675-ACAD_Source_Box-240528)	May-25
Signal Generator R&S SMB100A	SN: 182081	28-May-24 (No. 0001-300719404)	May-25
Mismatch; SMA	SN: 1102	22-May-24 (No. 675-Mismatch_SMA-240522)	May-25

	Name	Function	Signature
Calibrated by	Aidonia Georgiadou	Laboratory Technician	
Approved by	Sven Kühn	Technical Manager	
Issued: August 19, 2024			
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Accreditation No.: SCS 0108

Glossary

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards

- IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices - Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation

- DASY System Handbook

Methods Applied and Interpretation of Parameters

- *Measurement Conditions*: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL*: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss*: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay*: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured*: SAR measured at the stated antenna input power.
- *SAR normalized*: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters*: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY8 Module SAR	16.4.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom	
Distance Dipole Center - TSL	10 mm	with spacer
Zoom Scan Resolution	dx, dy = 5mm, dz = 1.5mm	Graded Ratio = 1.5 mm (Z direction)
Frequency	2550MHz $\pm$ 1MHz	

Head TSL parameters at 2550 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	39.1	1.91 mho/m
Measured Head TSL parameters	(22.0 $\pm$ 0.2)°C	37.5 $\pm$ 6%	1.95 mho/m $\pm$ 6%
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 2550 MHz

SAR averaged over 1 cm³ (1 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	24 dBm input power	13.6 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	54.1 W/kg $\pm$ 17.0% (k = 2)

SAR averaged over 10 cm³ (10 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	24 dBm input power	6.21 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	24.7 W/kg $\pm$ 16.5% (k = 2)

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters with Head TSL at 2550 MHz

Impedance	50.4 Ω – 1.3 j Ω
Return Loss	-37.4 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.151 ns
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After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured. The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
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System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D2550V2 - SN1015	2550	HSL	24

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10		CW, 0--	2550, 0	7.35	1.95	37.5

Hardware Setup

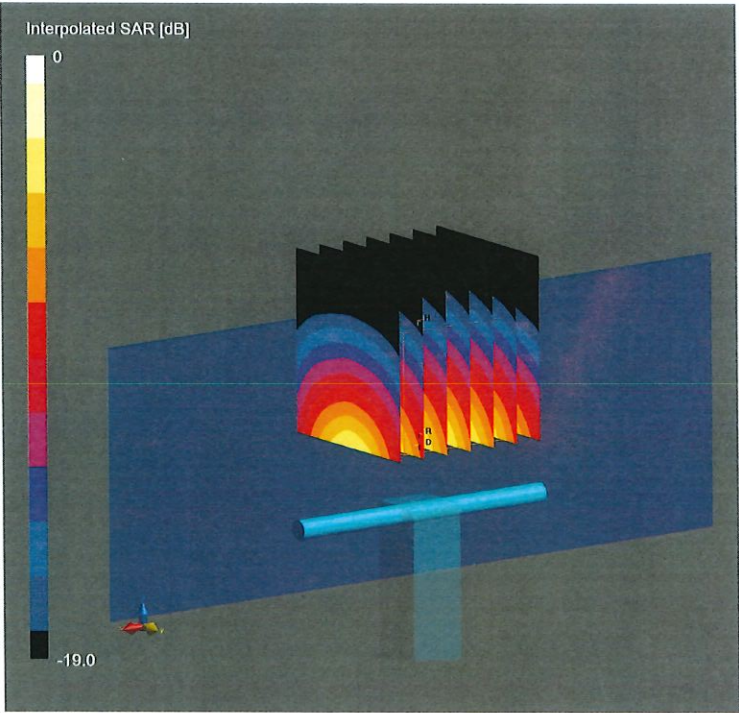
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2024-08-16	EX3DV4 - SN7349, 2024-06-03	DAE4ip Sn1836, 2024-01-10

Scans Setup

	Zoom Scan
Grid Extents [mm]	30 x 30 x 30
Grid Steps [mm]	5.0 x 5.0 x 1.5
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.5
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

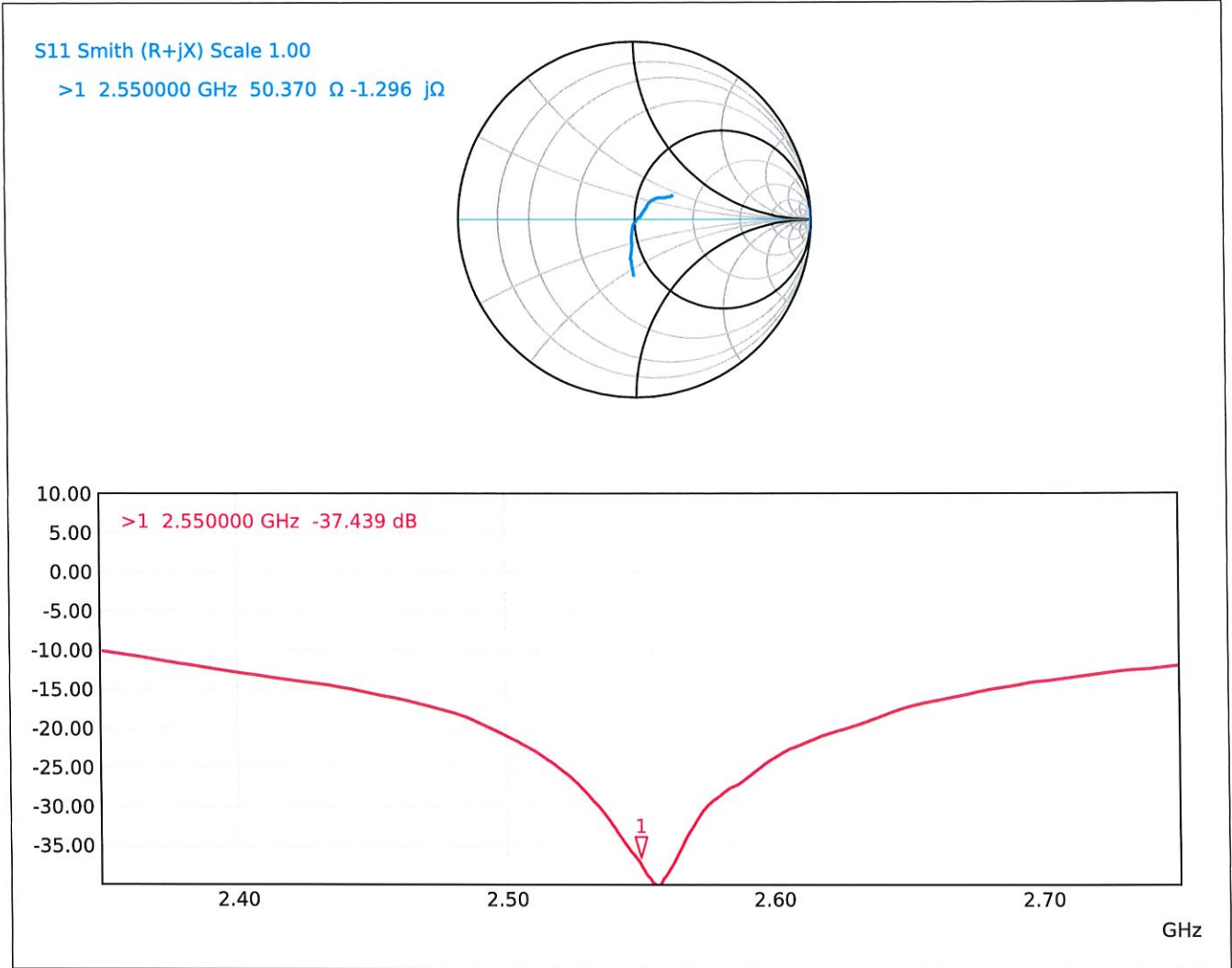
Measurement Results

	Zoom Scan
Date	2024-08-16
psSAR1g [W/Kg]	13.6
psSAR10g [W/Kg]	6.21
Power Drift [dB]	0.01
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



0 dB = 29.0 W/Kg

Impedance Measurement Plot for Head TSL





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Accreditation No.: **SCS 0108**

Client

WSCT
Shenzhen

Certificate No.

D5GHzV2-1412_Oct24

CALIBRATION CERTIFICATE

Object **D5GHzV2 - SN: 1412**

Calibration procedure(s) **QA CAL-22.v7**
Calibration Procedure for SAR Validation Sources between 3 - 10 GHz

Calibration date **October 17, 2024**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Cal
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Power Sensor R&S NRP18A	SN: 101859	22-Jul-24 (No. 4030A315008547)	Jul-25
Spectrum Analyzer R&S FSV40	SN: 101832	25-Jan-24 (No. 4030-315007551)	Jan-25
Mismatch; Short [S4188] Attenuator [S4423]	SN: 1152	28-Mar-24 (No. 217-04050)	Mar-25
OCP DAK-12	SN: 1016	24-Sep-24 (No. OCP-DAK12-1016_Sep24)	Sep-25
OCP DAK-3.5	SN: 1249	23-Sep-24 (No. OCP-DAK3.5-1249_Sep24)	Sep-25
Reference Probe EX3DV4	SN: 7349	03-Jun-24 (No. EX3-7349_Jun24)	Jun-25
DAE4ip	SN: 1836	10-Jan-24 (No. DAE4ip-1836_Jan24)	Jan-25

Secondary Standards	ID	Check Date (in house)	Scheduled Check
ACAD Source Box	SN: 1000	28-May-24 (No. 675-ACAD_Source_Box-240528)	May-25
Signal Generator R&S SMB100A	SN: 182081	28-May-24 (No. 675-CAL16-S4588-240528)	May-25
Mismatch; SMA	SN: 1102	22-May-24 (No. 675-Mismatch_SMA-240522)	May-25

	Name	Function	Signature
Calibrated by	Paulo Pina	Laboratory Technician	
Approved by	Sven Kühn	Technical Manager	

Issued: October 17, 2024

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Calibration Laboratory of

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Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
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S Swiss Calibration Service

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- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation

- DASY System Handbook

Methods Applied and Interpretation of Parameters

- *Measurement Conditions*: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL*: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss*: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay*: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured*: SAR measured at the stated antenna input power.
- *SAR normalized*: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters*: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY8 Module SAR	16.4.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom	
Distance Dipole Center - TSL	10 mm	with spacer
Zoom Scan Resolution	dx, dy = 4mm, dz = 1.4mm	Graded Ratio = 1.4 mm (Z direction)
Frequency	5200MHz $\pm$ 1MHz 5300MHz $\pm$ 1MHz 5500MHz $\pm$ 1MHz 5600MHz $\pm$ 1MHz 5800MHz $\pm$ 1MHz	

Head TSL parameters at 5200 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	36.0	4.66 mho/m
Measured Head TSL parameters	(22.0 $\pm$ 0.2)°C	35.9 $\pm$ 6%	4.51 mho/m $\pm$ 6%
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5200 MHz

SAR averaged over 1 cm³ (1 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	7.60 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	76.0 W/kg $\pm$ 19.9% (k = 2)

SAR averaged over 10 cm³ (10 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	2.20 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	22.0 W/kg $\pm$ 19.5% (k = 2)

Head TSL parameters at 5300 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.9	4.76 mho/m
Measured Head TSL parameters	(22.0 ±0.2)°C	35.7 ±6%	4.60 mho/m ±6%
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5300 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	8.06 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	80.6 W/kg ±19.9% (k = 2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	2.33 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	23.3 W/kg ±19.5% (k = 2)

Head TSL parameters at 5500 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.6	4.96 mho/m
Measured Head TSL parameters	(22.0 ±0.2)°C	35.3 ±6%	4.82 mho/m ±6%
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5500 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	8.56 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	85.6 W/kg ±19.9% (k = 2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	2.45 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	24.5 W/kg ±19.5% (k = 2)

Head TSL parameters at 5600 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.5	5.07 mho/m
Measured Head TSL parameters	(22.0 ±0.2)°C	35.1 ±6%	4.94 mho/m ±6%
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5600 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	8.33 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	83.3 W/kg ±19.9% (k = 2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	2.41 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	24.1 W/kg ±19.5% (k = 2)

Head TSL parameters at 5800 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.3	5.27 mho/m
Measured Head TSL parameters	(22.0 ±0.2)°C	34.9 ±6%	5.15 mho/m ±6%
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5800 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	7.90 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	79.0 W/kg ±19.9% (k = 2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	2.27 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	22.7 W/kg ±19.5% (k = 2)

Appendix (Additional assessments outside the scope of SCS 0108)**Antenna Parameters with Head TSL at 5200 MHz**

Impedance	53.3 Ω – 4.8 j Ω
Return Loss	-25.0 dB

Antenna Parameters with Head TSL at 5300 MHz

Impedance	48.4 Ω + 2.0 j Ω
Return Loss	-31.6 dB

Antenna Parameters with Head TSL at 5500 MHz

Impedance	47.6 Ω – 2.2 j Ω
Return Loss	-29.5 dB

Antenna Parameters with Head TSL at 5600 MHz

Impedance	55.9 Ω + 0.5 j Ω
Return Loss	-25.1 dB

Antenna Parameters with Head TSL at 5800 MHz

Impedance	50.5 Ω + 4.2 j Ω
Return Loss	-27.5 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.207 ns
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After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured. The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
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System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 - SN1412	5200	HSL	20

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10		CW, 0--	5200, 0	5.68	4.51	35.9

Hardware Setup

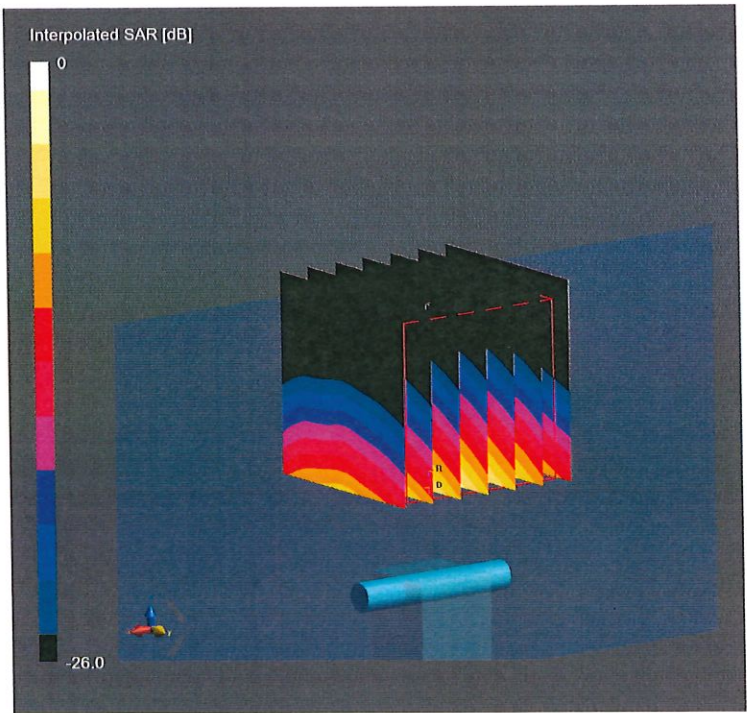
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2024-10-17	EX3DV4 - SN7349, 2024-06-03	DAE4ip Sn1836, 2024-01-10

Scans Setup

	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2024-10-17
psSAR1g [W/Kg]	7.60
psSAR10g [W/Kg]	2.20
Power Drift [dB]	0.00
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



0 dB = 30.4 W/Kg

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 - SN1412	5300	HSL	20

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10		CW, 0--	5300, 0	5.45	4.60	35.7

Hardware Setup

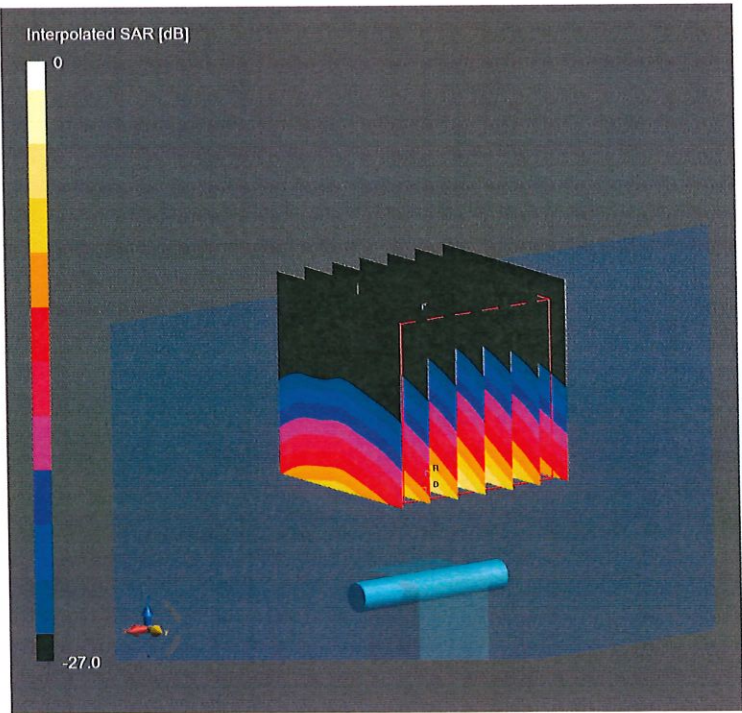
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2024-10-17	EX3DV4 - SN7349, 2024-06-03	DAE4lp Sn1836, 2024-01-10

Scans Setup

	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2024-10-17
psSAR1g [W/Kg]	8.06
psSAR10g [W/Kg]	2.33
Power Drift [dB]	0.00
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



0 dB = 33.1 W/Kg

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 - SN1412	5500	HSL	20

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10		CW, 0--	5500, 0	5.07	4.82	35.3

Hardware Setup

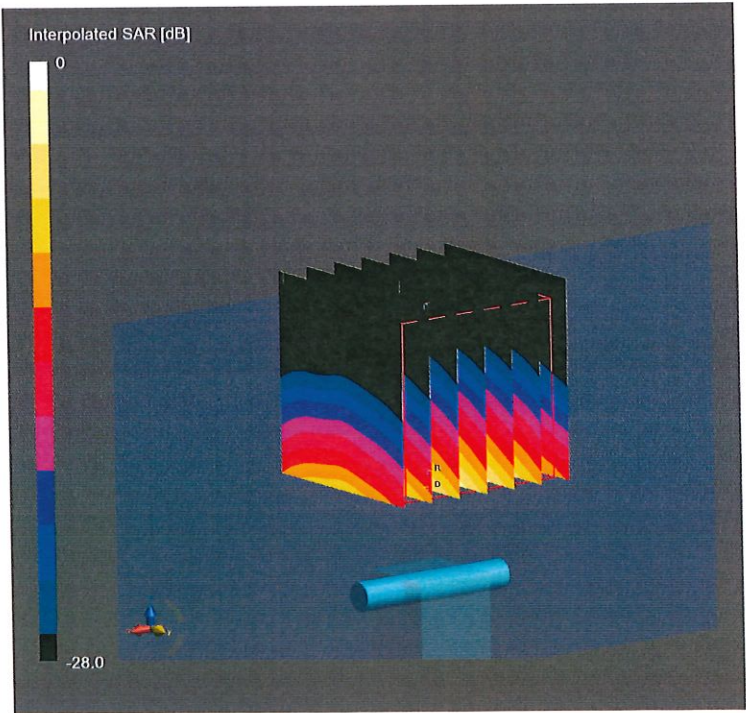
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2024-10-17	EX3DV4 - SN7349, 2024-06-03	DAE4ip Sn1836, 2024-01-10

Scans Setup

	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2024-10-17
psSAR1g [W/Kg]	8.56
psSAR10g [W/Kg]	2.45
Power Drift [dB]	0.00
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



0 dB = 36.7 W/Kg

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 - SN1412	5600	HSL	20

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10		CW, 0--	5600, 0	5.03	4.94	35.1

Hardware Setup

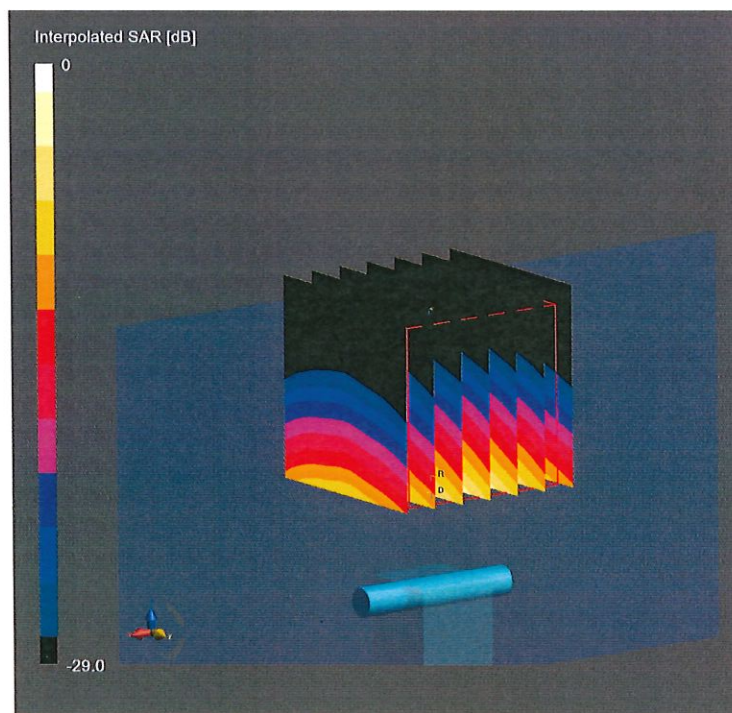
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2024-10-17	EX3DV4 - SN7349, 2024-06-03	DAE4ip Sn1836, 2024-01-10

Scans Setup

	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2024-10-17
psSAR1g [W/Kg]	8.33
psSAR10g [W/Kg]	2.41
Power Drift [dB]	0.00
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



System Performance Check Report

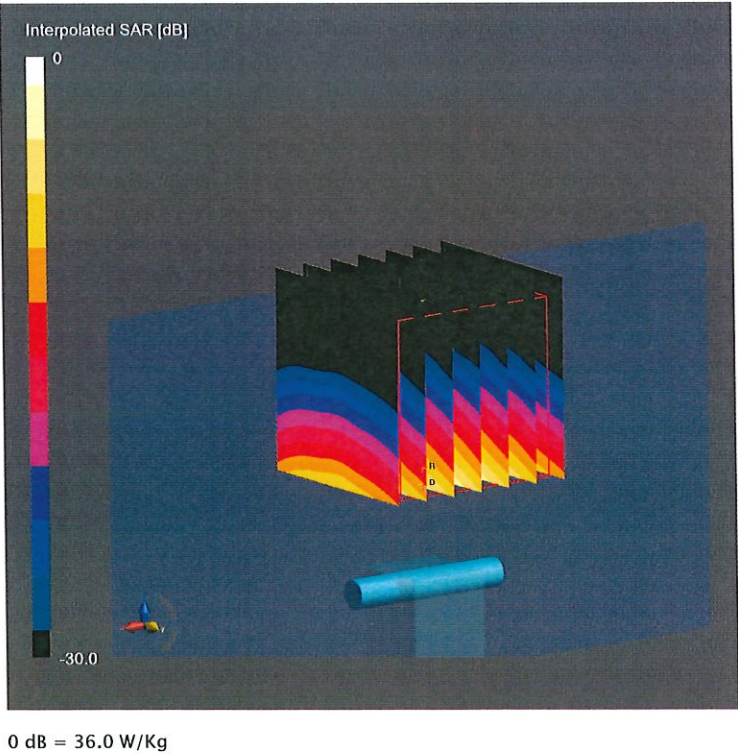
Summary			
Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 – SN1412	5800	HSL	20

Exposure Conditions							
Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10		CW, 0--	5800, 0	5.08	5.15	34.9

Hardware Setup			
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2024-10-17	EX3DV4 – SN7349, 2024-06-03	DAE4ip Sn1836, 2024-01-10

Scans Setup	
	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

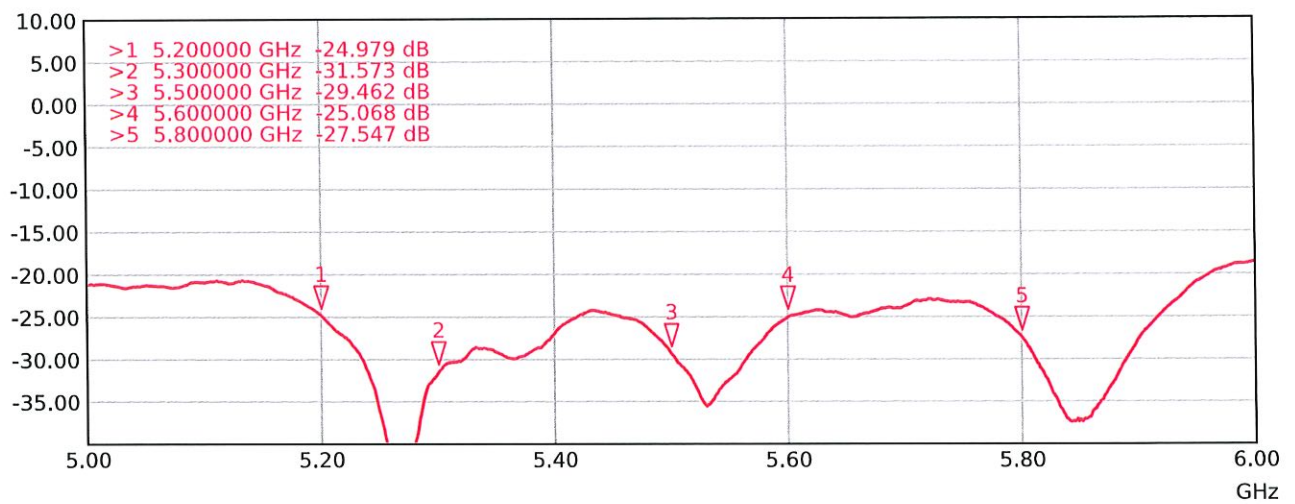
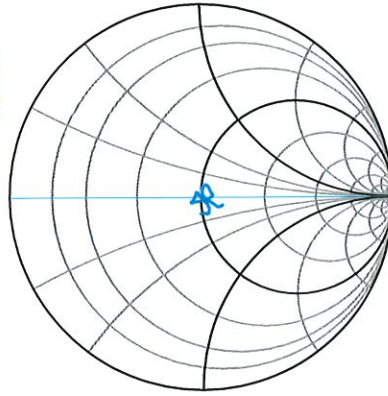
Measurement Results	
	Zoom Scan
Date	2024-10-17
psSAR1g [W/Kg]	7.90
psSAR10g [W/Kg]	2.27
Power Drift [dB]	-0.01
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



Impedance Measurement Plot for Head TSL

S11 Smith (R+jX) Scale 1.00

>1	5.200000 GHz	53.331 Ω	-4.787 j Ω
>2	5.300000 GHz	48.405 Ω	2.049 j Ω
>3	5.500000 GHz	47.552 Ω	-2.187 j Ω
>4	5.600000 GHz	55.889 Ω	0.477 j Ω
>5	5.800000 GHz	50.472 Ω	4.191 j Ω



IMPORTANT NOTICE

USAGE OF THE DAE4ip SN: 1921

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention must be given to the following points:

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration, pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, the customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

DASY Configuration Files: Since the exact values of the DAE input resistances, as measured during the calibration procedure of a DAE unit, are not used by the DASY software, a nominal value of 200 MOhm is given in the corresponding configuration file.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the calibration procedure.

Important Note:

To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.



Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Client **WSCT**
Shenzhen

Certificate No: **DAE4ip-1921_Sep25**

CALIBRATION CERTIFICATE

Object **DAE4ip - SD 000 D14 AG - SN: 1921**

Calibration procedure(s) **QA CAL-06.v30**
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: **September 04, 2025**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	15-Aug-25 (No:43873)	Aug-26
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Auto DAE Calibration Unit	SE UWS 053 AA 1001	23-Jan-25 (in house check)	In house check: Jan-26
Calibrator Box V2.1	SE UMS 006 AA 1002	23-Jan-25 (in house check)	In house check: Jan-26

	Name	Function	Signature
Calibrated by:	Timo Rott	Laboratory Technician	
Approved by:	Sven Kühn	Technical Manager	

Issued: September 4, 2025

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.



Accredited by the Swiss Accreditation Service (SAS)

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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Glossary

DAE	data acquisition electronics
Connector angle	information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle:* The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
 - *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
 - *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
 - *Input Offset Measurement:* Output voltage and statistical results over a large number of zero voltage measurements.
 - *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - *Input resistance:* Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - *Low Battery Alarm Voltage:* Typical value for information. Below this voltage, a battery alarm signal is generated.
 - *Power consumption:* Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	405.339 $\pm$ 0.02% (k=2)	405.748 $\pm$ 0.02% (k=2)	405.675 $\pm$ 0.02% (k=2)
Low Range	3.99724 $\pm$ 1.50% (k=2)	3.98942 $\pm$ 1.50% (k=2)	4.00806 $\pm$ 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	77.5 ° $\pm$ 1 °
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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	200003.68	1.60	0.00
Channel X	+ Input	20010.61	2.62	0.01
Channel X	- Input	-19994.77	2.48	-0.01
Channel Y	+ Input	200004.42	1.84	0.00
Channel Y	+ Input	20007.69	-0.26	-0.00
Channel Y	- Input	-19997.23	0.16	-0.00
Channel Z	+ Input	200002.59	0.37	0.00
Channel Z	+ Input	20007.41	-0.39	-0.00
Channel Z	- Input	-19998.21	-0.69	0.00

Low Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	2007.75	1.47	0.07
Channel X	+ Input	207.25	0.72	0.35
Channel X	- Input	-193.00	0.26	-0.14
Channel Y	+ Input	2007.15	0.90	0.04
Channel Y	+ Input	206.28	-0.23	-0.11
Channel Y	- Input	-194.22	-0.94	0.49
Channel Z	+ Input	2006.80	0.62	0.03
Channel Z	+ Input	205.63	-0.68	-0.33
Channel Z	- Input	-195.01	-1.56	0.81

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	0.47	-1.00
	- 200	1.61	0.55
Channel Y	200	2.60	1.95
	- 200	-3.09	-3.32
Channel Z	200	-16.60	-16.30
	- 200	14.45	14.40

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	0.13	-1.91
Channel Y	200	4.24	-	1.29
Channel Z	200	8.02	1.85	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15794	15541
Channel Y	15816	15550
Channel Z	15914	15220

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.24	-0.42	0.81	0.27
Channel Y	0.15	-1.17	0.96	0.37
Channel Z	-0.41	-1.33	0.68	0.34

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9